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#### SN74AVC4T774

SCES693D-FEBRUARY 2008-REVISED JANUARY 2015

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# SN74AVC4T774 4-Bit Dual-Supply Bus Transceiver With Configurable Voltage Translation and 3-State Outputs

Technical

Documents

#### 1 Features

- Each Channel Has an Independent DIR Control Input
- Control Inputs VIH/VIL Levels are Referenced to V<sub>CCA</sub> Voltage
- Fully Configurable Dual-Rail Design Allows Each Port to Operate Over the Full 1.2-V to 3.6-V Power-Supply Range
- I/Os are 4.6-V Tolerant
- Inff Supports Partial Power-Down-Mode Operation
- **Typical Data Rates** 
  - 380 Mbps (1.8-V to 3.3-V Translation)
  - 200 Mbps (<1.8-V to 3.3-V Translation)
  - 200 Mbps (Translate to 2.5 V or 1.8 V)
  - 150 Mbps (Translate to 1.5 V)
  - 100 Mbps (Translate to 1.2 V)
- Latch-Up Performance Exceeds 100 mA Per JESD 78, Class II
- ESD Protection Exceeds the Following Levels (Tested Per JESD 22)
  - ±8000-V Human-Body Model (A114-A)
  - 250-V Machine Model (A115-A) \_
  - ±1500-V Charged-Device Model (C101)

#### Applications 2

- Personal Electronic
- Industrial
- Enterprise
- Telecom

## 3 Description

Tools &

Software

This 4-bit noninverting bus transceiver uses two separate configurable power-supply rails. The A port is designed to track V\_{CCA}. V\_{CCA} accepts any supply voltage from 1.2 V to 3.6 V. The B port is designed to track V<sub>CCB</sub>. V<sub>CCB</sub> accepts any supply voltage from 1.2 to 3.6 V. The SN74AVC4T774 is optimized to operate with  $V_{CCA}/V_{CCB}$  set at 1.4 V to 3.6 V. It is operational with  $V_{\text{CCA}}/V_{\text{CCB}}$  as low as 1.2 V. This allows for universal low-voltage bi-directional translation between any of the 1.2-V, 1.5-V, 1.8-V, 2.5-V, and 3.3-V voltage nodes.

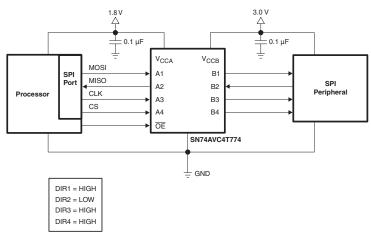
The SN74AVC4T774 is designed for asynchronous communication between data buses. The logic levels of the direction-control (DIR) input and the outputenable (OE) input activate either the B-port outputs or the A-port outputs or place both output ports in the high-impedance mode. The device transmits data from the A bus to the B bus when the B outputs are activated, and from the B bus to the A bus when the A outputs are activated. The input circuitry on both A and B ports is always active and must have a logic HIGH or LOW level applied to prevent excess I<sub>CC</sub> and I<sub>CCZ</sub>.

#### Device Information<sup>(1)</sup>

PART NUMBER	PACKAGE	BODY SIZE (NOM)
	TSSOP (16)	5.00 mm × 4.40 mm
SN74AVC4T774	VQFN (16)	4.00 mm × 3.50 mm
	UQFN (16)	2.60 mm × 1.80 mm

(1) For all available packages, see the orderable addendum at the end of the datasheet.

## **Typical Application Schematic**





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2

## **Table of Contents**

1	Feat	ures 1
2	App	lications 1
3	Dese	cription 1
4	Revi	sion History 2
5	Dese	cription (continued) 3
6	Pin (	Configuration and Functions 4
7	Spee	cifications
	7.1	Absolute Maximum Ratings 5
	7.2	ESD Ratings 5
	7.3	Recommended Operating Conditions 5
	7.4	Thermal Information 6
	7.5	Electrical Characteristics7
	7.6	Switching Characteristics $V_{CCA} = 1.2 \text{ V}$
	7.7	Switching Characteristics $V_{CCA} = 1.5 \text{ V} \pm 0.1 \text{ V} \dots 8$
	7.8	Switching Characteristics $V_{CCA} = 1.8 \text{ V} \pm 0.15 \text{ V} \dots 9$
	7.9	Switching Characteristics $V_{CCA} = 2.5 \text{ V} \pm 0.2 \text{ V} \dots 9$
	7.10	3
	7.11	Typical Characteristics 11

8	Para	meter Measurement Information	12
9	Deta	iled Description	. 13
	9.1	Overview	13
	9.2	Functional Block Diagram	13
	9.3	Feature Description	13
	9.4	Device Functional Modes	13
10	Арр	lication and Implementation	14
	10.1	Application Information	14
	10.2	Typical Application	14
11	Pow	ver Supply Recommendations	. 16
12	Lav	out	. 16
	-	Layout Guidelines	
	12.2	Layout Example	17
13	Dev	ice and Documentation Support	. 18
	13.1	Trademarks	18
	13.2	Electrostatic Discharge Caution	18
	13.3	Glossary	18
14	Mec	hanical, Packaging, and Orderable	
		rmation	. 18

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# **4** Revision History

C	hanges from Revision C (December 2014) to Revision D	Page
•	Changed Pin Functions table order for Pins B4, B3, B2 and B1	4

#### Changes from Revision B (May 2008) to Revision C

• Added Pin Configuration and Functions section, ESD Ratings table, Feature Description section, Device Functional Modes, Application and Implementation section, Power Supply Recommendations section, Layout section, Device 

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Page



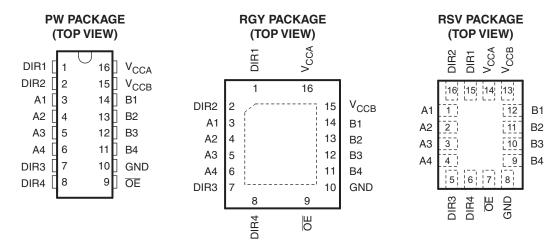
## **5** Description (continued)

The SN74AVC4T774 is designed so that the control pins (DIR1, DIR2, DIR3, DIR4, and  $\overline{OE}$ ) are supplied by V<sub>CCA</sub>. This device is fully specified for partial-power-down applications using I<sub>off</sub>. The I<sub>off</sub> circuitry disables the outputs, preventing damaging current backflow through the device when it is powered down. The V<sub>CC</sub> isolation feature ensures that if either V<sub>CC</sub> input is at GND, then both ports are in the high-impedance state.

To ensure the high-impedance state during power-up or power-down,  $\overline{OE}$  should be tied to V<sub>CCA</sub> through a pullup resistor; the minimum value of the resistor is determined by the current-sinking capability of the driver. Since this device has CMOS inputs, it is very important to not allow them to float. If the inputs are not driven to either a high V<sub>CC</sub> state, or a low-GND state, an undesirable larger than expected I<sub>CC</sub> current may result. Since the input voltage settlement is governed by many factors (for example, capacitance, board-layout, package inductance, surrounding conditions, and so forth), ensuring that they these inputs are kept out of erroneous switching states and tying them to either a high or a low level minimizes the leakage-current.



## 6 Pin Configuration and Functions



(1) Shown for a single channel

#### Pin Functions

PIN							
NAME PW RGY RSV			I/O	DESCRIPTION			
DIR1	1	15	I	Direction-control input for '1' channel			
DIR2	2	16	I	Direction-control input for '2' channel			
A1	3	1	I/O	Input/output A1. Referenced to V <sub>CCA</sub>			
A2	4	2	I/O	Input/output A2. Referenced to V <sub>CCA</sub>			
A3	5	3	I/O	Input/output A3. Referenced to V <sub>CCA</sub>			
A4	6	4	I/O	Input/output A4. Referenced to V <sub>CCA</sub>			
DIR3	7	5	I	Direction-control input for '3' channel			
DIR4	8	6	I	Direction-control input for '4' channel			
OE	9	7	I	3-state output-mode enables. Pull $\overline{\text{OE}}$ high to place all outputs in 3-state mode. Referenced to $V_{\text{CCA}}.$			
GND	10	8	G	Ground			
B4	11	9	I/O	Input/output B4. Referenced to V <sub>CCB</sub>			
B3	12	10	I/O	Input/output B3. Referenced to V <sub>CCB</sub>			
B2	13	11	I/O	Input/output B2. Referenced to V <sub>CCB</sub>			
B1	14	12	I/O	Input/output B1. Referenced to V <sub>CCB</sub>			
V <sub>CCB</sub>	15	13	Р	B-port supply voltage. 1.2 V $\leq$ V <sub>CCB</sub> $\leq$ 3.6 V			
V <sub>CCA</sub>	16	14	Р	A-port supply voltage. 1.2 V $\leq$ V <sub>CCA</sub> $\leq$ 3.6 V			



## 7 Specifications

## 7.1 Absolute Maximum Ratings

over operating free-air temperature range (unless otherwise noted)<sup>(1)</sup>

			MIN	MAX	UNIT
V <sub>CCA</sub> V <sub>CCB</sub>	Supply voltage	-0.5	4.6	V	
		I/O ports (A port)	-0.5	4.6	
VI	Input voltage <sup>(2)</sup>	I/O ports (B port)	-0.5	4.6	V
		Control inputs	-0.5	4.6	
V	Voltage applied to any output in the high-impedance or power-off	A port	-0.5	4.6	V
Vo	state <sup>(2)</sup>	B port	-0.5	4.6	v
V	Vales a seclical to see subset is the high seclet state $(2)(3)$	A port	-0.5	V <sub>CCA</sub> + 0.5	V
Vo	Voltage applied to any output in the high or low state <sup>(2)(3)</sup>	B port	-0.5	V <sub>CCB</sub> + 0.5	V
I <sub>IK</sub>	Input clamp current	V <sub>I</sub> < 0		-50	mA
I <sub>OK</sub>	Output clamp current	V <sub>O</sub> < 0		-50	mA
I <sub>O</sub>	Continuous output current			±50	mA
	Continuous current through $V_{CCA}$ , $V_{CCB}$ , or GND		±100	mA	
T <sub>stg</sub>	Storage temperature, T <sub>stg</sub>		-65	150	°C

(1) Stresses beyond those listed under Absolute Maximum Ratings may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under Recommended Operating Conditions is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

(2) The input voltage and output negative-voltage ratings may be exceeded if the input and output current ratings are observed.

(3) The output positive-voltage rating may be exceeded up to 4.6 V maximum if the output current rating is observed.

## 7.2 ESD Ratings

			VALUE	UNIT
	Human-body model (HBM), per ANSI/ESDA/JEDEC JS-001 <sup>(1)</sup>	±8000		
V <sub>(ESD)</sub>	V <sub>(ESD)</sub> Electrostatic discharge	Charged-device model (CDM), per JEDEC specification JESD22-C101 $^{\rm (2)}$	±1500	V
		Machine Model (A115-A)	250	

(1) JEDEC document JEP155 states that 500-V HBM allows safe manufacturing with a standard ESD control process.

(2) JEDEC document JEP157 states that 250-V CDM allows safe manufacturing with a standard ESD control process.

### 7.3 Recommended Operating Conditions

See (1)(2)(3).

		V <sub>CCI</sub>	V <sub>cco</sub>	MIN	MAX	UNIT
$V_{CCA}$	Supply voltage			1.2	3.6	V
V <sub>CCB</sub>	Supply voltage			1.2	3.6	V
	High-level Dat	1.2 V to 1.95 V		V <sub>CCI</sub> × 0.65		
VIH		1.95 V to 2.7 V		1.6		V
		2.7 V to 3.6 V		2		
		1.2 V to 1.95 V			V <sub>CCI</sub> × 0.35	
VIL	Low-level input voltage	1.95 V to 2.7 V			0.7	V
	input voltage	2.7 V to 3.6 V			0.8	

(1)  $V_{CCI}$  is the  $V_{CC}$  associated with the input port.

(2)  $V_{CCO}$  is the  $V_{CC}$  associated with the output port.

(3) All unused data inputs of the device must be held at V<sub>CCI</sub> or GND to ensure proper device operation. Refer to the TI application report, Implications of Slow or Floating CMOS Inputs, literature number SCBA004.

(4) For V<sub>CCI</sub> values not specified in the data sheet,  $V_{IH}$  min =  $V_{CCI} \times 0.7$  V,  $V_{IL}$  max =  $V_{CCI} \times 0.3$  V

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## **Recommended Operating Conditions (continued)**

See (1)(2)(3).

			V <sub>CCI</sub>	V <sub>cco</sub>	MIN	MAX	UNIT
		DIR	1.2 V to 1.95 V		$V_{CCA} \times 0.65$		
VIH	High-level input voltage	(referenced to $V_{CCA}$ ) <sup>(5)</sup>	1.95 V to 2.7 V		1.6		V
	input voltage	(DIRx, OE)	2.7 V to 3.6 V		2		
		DIR	1.2 V to 1.95 V			$V_{CCA} \times 0.35$	
VIL	Low-level input voltage	(referenced to V <sub>CCA</sub> ) <sup>(5)</sup>	1.95 V to 2.7 V			0.7	V
	input voltage	$(DIRx, \overline{OE})$	2.7 V to 3.6 V			0.8	
VI	Input voltage				0	3.6	V
V	Output voltogo	Active state			0	V <sub>cco</sub>	V
Vo	Output voltage	3-state			0	3.6	V
				1.1 V to 1.2 V		-3	
				1.4 V to 1.6 V		-6	
I <sub>OH</sub>	High-level output current			1.65 V to 1.95 V		-8	mA
				2.3 V to 2.7 V		-9	
				3 V to 3.6 V		-12	
				1.1 V to 1.2 V		3	
				1.4 V to 1.6 V		6	
I <sub>OL</sub>	Low-level output cu	irrent		1.65 V to 1.95 V		8	mA
				2.3 V to 2.7 V		9	
				3 V to 3.6 V		12	
Δt/Δv	Input transition rise	or fall rate				5	ns/V
T <sub>A</sub>	Operating free-air to	emperature			-40	85	°C

(5) For V<sub>CCA</sub> values not specified in the data sheet, V<sub>IH</sub> min = V<sub>CCA</sub> × 0.7 V, V<sub>IL</sub> max = V<sub>CCA</sub> × 0.3 V

#### 7.4 Thermal Information

			SN74AVC4T774				
	THERMAL METRIC <sup>(1)</sup>	PW	RGY	RSV	UNIT		
		16 PINS	16 PINS	16 PINS			
$R_{\theta JA}$	Junction-to-ambient thermal resistance	118.2	37.7	139.2			
R <sub>0JC(top)</sub>	Junction-to-case (top) thermal resistance	52.8	56.1	64.9			
$R_{\theta JB}$	Junction-to-board thermal resistance	63.3	15.9	67.7	°C/W		
Ψ <sub>JT</sub>	Junction-to-top characterization parameter	8.8	0.5	1.7	0.00		
$\Psi_{JB}$	Junction-to-board characterization parameter	62.7	16.1	67.4			
R <sub>0JC(bot)</sub>	Junction-to-case (bottom) thermal resistance	N/A	N/A	N/A			

(1) For more information about traditional and new thermal metrics, see the IC Package Thermal Metrics application report, SPRA953.



## 7.5 Electrical Characteristics<sup>(1)(2)(3)</sup>

over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER		TEST COND		V	V	Τ <sub>4</sub>	, = 25°C		–40°C	to 85°C	;	UNI	
		TEST COND	TIONS	V <sub>CCA</sub>	V <sub>CCB</sub>	MIN	TYP	MAX	MIN	TYP	MAX	UNI	
		I <sub>OH</sub> = −100 μA		1.2 V to 3.6 V	1.2 V to 3.6 V				V <sub>CCO</sub> – 0.2				
		I <sub>OH</sub> = -3 mA		1.2 V	1.2 V		0.95						
V <sub>он</sub>		$I_{OH} = -6 \text{ mA}$	$V_{I} = V_{IH}$	1.4 V	1.4 V				1.05			v	
		$I_{OH} = -8 \text{ mA}$		1.65 V	1.65 V				1.2				
		I <sub>OH</sub> = -9 mA		2.3 V	2.3 V				1.75				
		$I_{OH} = -12 \text{ mA}$		3 V	3 V				2.3				
		I <sub>OL</sub> = 100 μA		1.2 V to 3.6 V	1.2 V to 3.6 V						0.2		
		$I_{OL} = 3 \text{ mA}$		1.2 V	1.2 V		0.25						
V <sub>OL</sub>		$I_{OL} = 6 \text{ mA}$	$V_I = V_{IL}$	1.4 V	1.4 V						0.35	V	
		$I_{OL} = 8 \text{ mA}$		1.65 V	1.65 V						0.45		
		$I_{OL} = 9 \text{ mA}$	-	2.3 V	2.3 V						0.55		
		I <sub>OL</sub> = 12 mA		3 V	3 V						0.7		
I	Control inputs	$V_{I} = V_{CCA}$ or GND		1.2 V to 3.6 V	1.2 V to 3.6 V		±0.025	±0.25			±1	μA	
1	A or B $V_1$ or $V_0 = 0$ to 3.6 V		6 V	0 V	0 V to 3.6 V		±0.1	±1			±5	μA	
off	port	$v_1 0 v_0 = 0.003.$	0 0	0 V to 3.6 V	0 V		±0.1	±1			±5	μ	
l <sub>oz</sub>	A or B port	$V_0 = V_{CC0}$ or GN $V_1 = V_{CC1}$ or GND	ID <u>,</u> , OE = V <sub>IH</sub>	3.6 V	3.6 V		±0.5	±2.5			±5	μA	
				1.2 V to 3.6 V	1.2 V to 3.6 V						8		
CCA		$V_{I} = V_{CCI}$ or GND	$I_{0} = 0$	0 V	0 V to 3.6 V						-2	μ	
				0 V to 3.6 V	0 V						8		
				1.2 V to 3.6 V	1.2 V to 3.6 V						8		
I <sub>CCB</sub>		$V_I = V_{CCI}$ or GND	, I <sub>O</sub> = 0	0 V	0 V to 3.6 V						8	μı	
				0 V to 3.6 V	0 V						-2	-	
I <sub>CCA</sub> +	I <sub>CCB</sub>	$V_{I} = V_{CCI} \text{ or } GND$	, I <sub>O</sub> = 0	1.2 V to 3.6 V	1.2 V to 3.6 V						16	μA	
C <sub>i</sub>	Control inputs	V <sub>I</sub> = 3.3 V or GNI	D	3.3 V	3.3 V		2.5				3	pł	
C <sub>io</sub>	A or B port	V <sub>O</sub> = 3.3 V or GN	ID	3.3 V	3.3 V		5				6	pl	

(1) All unused control inputs of the device must be held at VCC or GND to ensure proper device operation. Refer to the TI application report, Implications of Slow or Floating CMOS Inputs, literature number SCBA004.  $V_{CCO}$  is the  $V_{CC}$  associated with the output port.  $V_{CCI}$  is the  $V_{CC}$  associated with the input port.

(2)

(3)

SN74AVC4T774

SCES693D - FEBRUARY 2008 - REVISED JANUARY 2015

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TRUMENTS

EXAS

## 7.6 Switching Characteristics $V_{CCA} = 1.2 V$

over recommended operating free-air temperature range,  $V_{CCA} = 1.2 \text{ V}$  (unless otherwise noted) (see Figure 3)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	V <sub>CCB</sub> = 1.2 V	V <sub>CCB</sub> = 1.5 V ± 0.1 V	V <sub>CCB</sub> = 1.8 V ± 0.15 V	V <sub>CCB</sub> = 2.5 V ± 0.2 V	V <sub>CCB</sub> = 3.3 V ± 0.3 V	UNIT
	(INPOT)	(001201)	TYP	ТҮР	TYP	TYP	TYP	
t <sub>PLH</sub>	А	D	3.5	2.8	2.7	2.7	3.1	
t <sub>PHL</sub>	A	В	3.5	2.8	2.7	2.7	3.1	ns
t <sub>PLH</sub>	D	^	3.8	3.4	3.2	3	2.9	-
t <sub>PHL</sub>	В	A	3.8	3.4	3.2	3	2.9	ns
t <sub>PZH</sub>	OE	^	6	4.8	4.4	5.3	9.3	-
t <sub>PZL</sub>	OE	A	6	4.8	4.4	5.3	9.3	ns
t <sub>PZH</sub>	OE	P	6.7	6.7	6.6	6.7	6.6	
t <sub>PZL</sub>	OE	В	6.7	6.7	6.6	6.7	6.6	ns
t <sub>PHZ</sub>	OE	•	4.3	3.6	3.7	3.3	4	
t <sub>PLZ</sub>	OE	A	4.3	3.6	3.7	3.3	4	ns
t <sub>PHZ</sub>	OE	Р	4.4	4.4	4.4	4.4	4.4	20
t <sub>PLZ</sub>	0E	В	4.4	4.4	4.4	4.4	4.4	ns

## 7.7 Switching Characteristics $V_{CCA} = 1.5 V \pm 0.1 V$

over recommended operating free-air temperature range,  $V_{CCA} = 1.5 \text{ V} \pm 0.1 \text{ V}$  (see Figure 3)

PARAMETER	FROM	TO (OUTPUT)	V <sub>CCB</sub> = 1.2 V		V <sub>CCB</sub> = 1.5 V ± 0.1 V		V <sub>CCB</sub> = 1.8 V ± 0.15 V		2.5 V 2 V	V <sub>CCB</sub> = 3.3 V ± 0.3 V		UNIT				
	(INPUT)		TYP	MIN	MAX	MIN	MAX	MIN	MAX	MIN	MAX					
t <sub>PLH</sub>	А	В	3.1	0.3	4.4	0.2	3.9	0.1	3.6	0.1	3.9	20				
t <sub>PHL</sub>	A	D	3.1	0.3	4.4	0.2	3.9	0.1	3.6	0.1	3.9	ns				
t <sub>PLH</sub>	В	А	2.9	0.6	5.1	0.4	4.9	0.2	4.6	0.1	4.5					
t <sub>PHL</sub>	Б	A	2.9	0.6	5.1	0.4	4.9	0.2	4.6	0.1	4.5	ns				
t <sub>PZH</sub>	OE	А	5.3	1.1	7.1	0.9	6.2	0.7	5.5	0.1	6.4	ns				
t <sub>PZL</sub>	OE	A	5.3	1.1	7.1	0.9	6.2	0.7	5.5	0.1	6.4					
t <sub>PZH</sub>	OE	В	4.4	1.1	8.2	1.1	8.2	1.1	8.2	1.1	8.2					
t <sub>PZL</sub>	UE	D	4.4	1.1	8.2	1.1	8.2	1.1	8.2	1.1	8.2	ns				
t <sub>PHZ</sub>	OE	А	3.6	1.2	4.8	0.8	5.4	0.4	5.1	1	5.4					
t <sub>PLZ</sub>	UE	A	3.6	1.2	4.8	0.8	5.4	0.4	5.1	1	5.4	ns				
t <sub>PHZ</sub>	OE	P	3.1	0.3	5.6	0.2	5.7	0.3	5.6	0.3	56					
t <sub>PLZ</sub>	UE	B	В	В	В	В	3.1	0.3	5.6	0.2	5.7	0.3	5.6	0.3	5.6	ns



## 7.8 Switching Characteristics $V_{CCA} = 1.8 V \pm 0.15 V$

over recommended operating free-air temperature range,  $V_{CCA} = 1.8 \text{ V} \pm 0.15 \text{ V}$  (see Figure 3)

PARAMETER	FROM	TO	V <sub>CCB</sub> = 1.2 V	V <sub>CCB</sub> = ± 0.7	1.5 V I V	V <sub>CCB</sub> = 1.8 V ± 0.15 V		V <sub>CCB</sub> = 2.5 V ± 0.2 V		V <sub>CCB</sub> = 3.3 V ± 0.3 V		UNIT
	(INPUT)	(OUTPUT)	TYP	MIN	MAX	MIN	MAX	MIN	MAX	MIN	MAX	
t <sub>PLH</sub>	А	В	2.8	0.1	4.1	0.1	3.6	0.1	3.1	0.1	3.3	20
t <sub>PHL</sub>	A	D	2.8	0.1	4.1	0.1	3.6	0.1	3.1	0.1	3.3	ns
t <sub>PLH</sub>	в	А	2.6	0.4	4.3	0.1	4.1	0.1	3.8	0.1	3.7	20
t <sub>PHL</sub>	Ь	A	2.6	0.4	4.3	0.1	4.1	0.1	3.8	0.1	3.7	ns
t <sub>PZH</sub>	OE	А	5	0.8	6.7	0.6	5.8	0.4	4.8	0.3	4.6	ns
t <sub>PZL</sub>	OE	A	5	0.8	6.7	0.6	5.8	0.4	4.8	0.3	4.6	
t <sub>PZH</sub>	OE	В	3.3	0.2	6.7	0.2	6.6	0.2	6.7	0.2	6.7	20
t <sub>PZL</sub>	UE	D	3.3	0.2	6.7	0.2	6.6	0.2	6.7	0.2	6.7	ns
t <sub>PHZ</sub>	OE	^	3.4	0.7	4.7	0.3	5.1	0.1	4.5	0.8	5	20
t <sub>PLZ</sub>	UE	A	3.4	0.7	4.7	0.3	5.1	0.1	4.5	0.8	5	ns
t <sub>PHZ</sub>	OE	В	2.9	0.1	5.7	0.1	5.8	0.1	5.8	0.1	5.8	20
t <sub>PLZ</sub>	UE	D	2.9	0.1	5.7	0.1	5.8	0.1	5.8	0.1	5.8	ns

## 7.9 Switching Characteristics $V_{CCA} = 2.5 V \pm 0.2 V$

over recommended operating free-air temperature range,  $V_{CCA} = 2.5 \text{ V} \pm 0.2 \text{ V}$  (see Figure 3)

PARAMETER	FROM	TO	V <sub>CCB</sub> = 1.2 V		V <sub>CCB</sub> = 1.5 V ± 0.1 V		V <sub>CCB</sub> = 1.8 V ± 0.15 V		2.5 V 2 V	V <sub>CCB</sub> = 3.3 V ± 0.3 V		UNIT		
	(INPUT)	(OUTPUT)	TYP	MIN	MAX	MIN	MAX	MIN	MAX	MIN	MAX			
t <sub>PLH</sub>	А	В	2.6	0.1	3.8	0.1	3.2	0.1	2.7	0.1	2.6	20		
t <sub>PHL</sub>	A	D	2.6	0.1	3.8	0.1	3.2	0.1	2.7	0.1	2.6	ns		
t <sub>PLH</sub>	В	•	2.5	0.5	3.4	0.2	3.1	0.1	2.8	0.1	2.6	ns		
t <sub>PHL</sub>	Б	A	2.5	0.5	3.4	0.2	3.1	0.1	2.8	0.1	2.6			
t <sub>PZH</sub>	OE	А	4.7	0.7	6.2	0.5	5.2	0.3	4.1	0.3	3.6	ns		
t <sub>PZL</sub>	UE	A	4.7	0.7	6.2	0.5	5.2	0.3	4.1	0.3	3.6			
t <sub>PZH</sub>	OE	В	2.3	0.4	4.5	0.4	4.5	0.4	4.5	0.4	4.5			
t <sub>PZL</sub>	ÛE	В	2.3	0.4	4.5	0.4	4.5	0.4	4.5	0.4	4.5	ns		
t <sub>PHZ</sub>	OE	А	3	0.2	4.3	0.1	4.9	0.1	4	0.7	4.3	20		
t <sub>PLZ</sub>	UE	A	3	0.2	4.3	0.1	4.9	0.1	4	0.7	4.3	ns		
t <sub>PHZ</sub>	OE B	В	2		1.9	01	4.7	0.1	4.6	0.1	4.7	0.1	4.7	
t <sub>PLZ</sub>	UE		1.9	01	4.7	0.1	4.6	0.1	4.7	0.1	4.7	ns		

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### SN74AVC4T774

SCES693D - FEBRUARY 2008 - REVISED JANUARY 2015

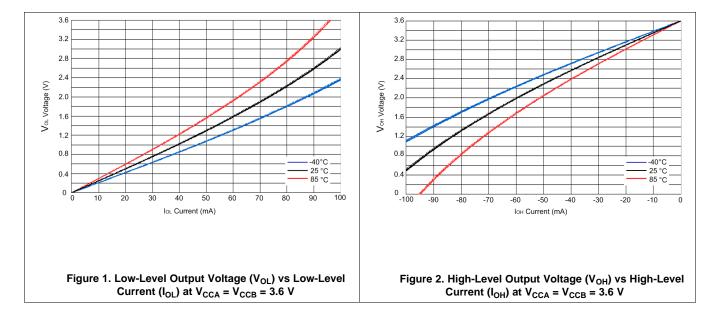
## 7.10 Switching Characteristics V<sub>CCA</sub> = 3.3 V $\pm$ 0.3 V

## over recommended operating free-air temperature range, V<sub>CCA</sub> = 3.3 V $\pm$ 0.3 V (see Figure 3)

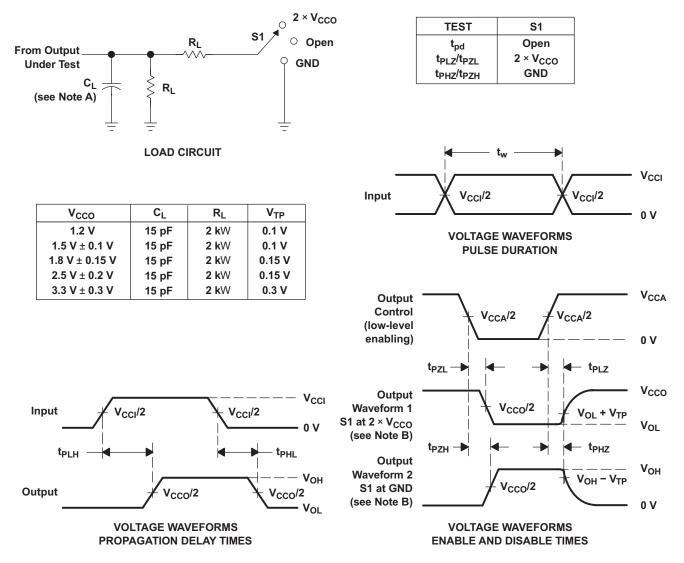
PARAMETER	FROM	TO	V <sub>CCB</sub> = 1.2 V	V <sub>CCB</sub> = ± 0.1	V <sub>CCB</sub> = 1.5 V ± 0.1 V		V <sub>CCB</sub> = 1.8 V ± 0.15 V		2.5 V 2 V	V <sub>CCB</sub> = 3.3 V ± 0.3 V		UNIT					
	(INPUT)	(OUTPUT)	TYP	MIN	MAX	MIN	MAX	MIN	MAX	MIN	MAX						
t <sub>PLH</sub>	А	В	2.5	0.1	3.6	0.1	3	0.1	2.6	0.1	2.4	20					
t <sub>PHL</sub>	A	Б	2.5	0.1	3.6	0.1	3	0.1	2.6	0.1	2.4	ns					
t <sub>PLH</sub>	В	^	2.6	0.5	3.4	0.2	2.9	0.1	2.5	0.1	2.3	20					
t <sub>PHL</sub>	Б	A	2.6	0.5	3.4	0.2	2.9	0.1	2.5	0.1	2.3	ns					
t <sub>PZH</sub>	OE	А	4.5	0.9	5.9	0.5	5	0.3	3.8	0.3	3.3	20					
t <sub>PZL</sub>	ÛE	A	3.8	0.9	5.9	0.5	5	0.3	3.8	0.3	3.3	3.3 ns					
t <sub>PZH</sub>	OE	В	1.9	0.4	3.6	0.4	3.6	0.4	3.6	0.4	3.6	20					
t <sub>PZL</sub>	ÛE	В	1.9	0.4	3.6	0.4	3.6	0.4	3.6	0.4	3.6	ns					
t <sub>PHZ</sub>	OE	•	2.7	0.1	4.2	0.1	4.6	0.3	3.8	0.7	3.9						
t <sub>PLZ</sub>	UE	A	A	A	A	A	A	2.7	0.1	4.2	0.1	4.6	0.3	3.8	0.7	3.9	ns
t <sub>PHZ</sub>	OE B	В	6	<b>_</b>	2.3	0.1	4.5	0.1	4.5	0.1	4.6	0.1	4.6	20			
t <sub>PLZ</sub>	UE		2.3	0.1	4.5	0.1	4.5	0.1	4.6	0.1	4.6	ns					



## 7.11 Typical Characteristics



### 8 Parameter Measurement Information



NOTES: A. C<sub>L</sub> includes probe and jig capacitance.

- B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high, except when disabled by the output control.
- C. All input pulses are supplied by generators having the following characteristics: PRR 10 MHz,  $Z_{O} = 50$  W, dv/dt  $\ge 1$  V/ns.
- D. The outputs are measured one at a time, with one transition per measurement.
- E.  $t_{PLZ}$  and  $t_{PHZ}$  are the same as  $t_{dis}$ .
- F.  $t_{PZL}$  and  $t_{PZH}$  are the same as  $t_{en}$ .
- G.  $t_{PLH}$  and  $t_{PHL}$  are the same as  $t_{pd}$ .
- H.  $V_{CCI}$  is the  $V_{CC}$  associated with the input port.
- I.  $V_{CCO}$  is the  $V_{CC}$  associated with the output port.

#### Figure 3. Load and Circuit and Voltage Waveforms



## 9 Detailed Description

### 9.1 Overview

The SN74AVC4T774 is a 4-bit, dual-supply, noninverting, bi-directional voltage level translation. Pins An and control pins (DIR1, DIR2, DIR3, DIR4 and OE) are support by  $V_{CCA}$  and pins Bn are support by  $V_{CCB}$ . The A port is able to accept I/O voltages ranging from 1.2 V to 3.6 V, while the B port can accept I/O voltages from 1.2 V to 3.6 V. A high on DIR allows data transmission from An to Bn and a low on DIR allows data transmission from B to A when OE is set to low. When OE is set to high, both An and Bn are in the high-impedance state.

### 9.2 Functional Block Diagram

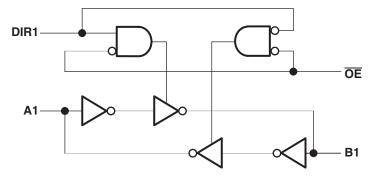


Figure 4. Logic Diagram (Positive Logic)

#### 9.3 Feature Description

# 9.3.1 Fully Configurable Dual-Rail Design Allows Each Port to Operate Over the Full 1.2-V to 3.6-V Power-Supply Range

Both  $V_{CCA}$  and  $V_{CCB}$  can be supplied at any voltage between 1.2 V and 3.6 V making the device suitable for translating between any of the low-voltage nodes (1.2 V, 1.8 V, 2.5 V and 3.3 V).

#### 9.3.2 Support High-Speed Translation

SN74AVC4T774 can support high data rate application. The translated signal data rate can be up to 380 Mbps when signal is translated from 1.8 V to 3.3 V.

#### 9.3.3 I<sub>off</sub> Supports Partial-Power-Down Mode Operation

I<sub>off</sub> will prevent backflow current by disabling I/O output circuits when device is in partial-power-down mode.

### 9.4 Device Functional Modes

CONTI	CONTROL INPUTS		OUTPUT CIRCUITS								
OE	DIR	A PORT	B PORT	OPERATION							
L	L	Enabled	Hi-Z	B data to A data							
L	Н	Hi-Z	Enabled	A data to B data							
Н	Х	Hi-Z	Hi-Z	Isolation							

#### Table 1. Function Table (Each Bit)

## **10** Application and Implementation

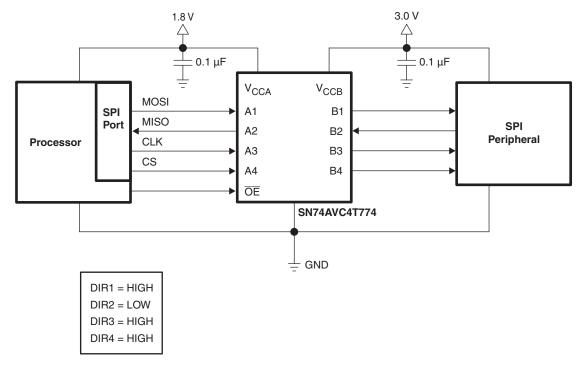
#### NOTE

Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes. Customers should validate and test their design implementation to confirm system functionality.

#### **10.1** Application Information

The SN74AVC4T774 device can be used in level-translation applications for interfacing devices or systems operating at different interface voltages with one another. The SN74AVC4T774 device is ideal for use in applications where a push-pull driver is connected to the data I/Os. Its max data rate can be up to 380 Mbps when device translate signal from 1.8 V to 3.3 V.

### **10.2 Typical Application**





#### 10.2.1 Design Requirements

For this design example, use the parameters listed in Table 2.

	-
DESIGN PARAMETERS	EXAMPLE VALUE
Input Voltage Range	1.2 V to 3.6 V
Output Voltage Range	1.2 V to 3.6 V



#### 10.2.2 Detailed Design Procedure

To begin the design process, determine the following:

- Input voltage range
  - Use the supply voltage of the device that is driving the SN74AVC4T774 device to determine the input voltage range. For a valid logic high, the value must exceed the  $V_{IH}$  of the input port. For a valid logic low, the value must be less than the  $V_{IL}$  of the input port.
- Output voltage range
  - Use the supply voltage of the device that the SN74AVC4T774 device is driving to determine the output voltage range.

#### 10.2.3 Application Curve

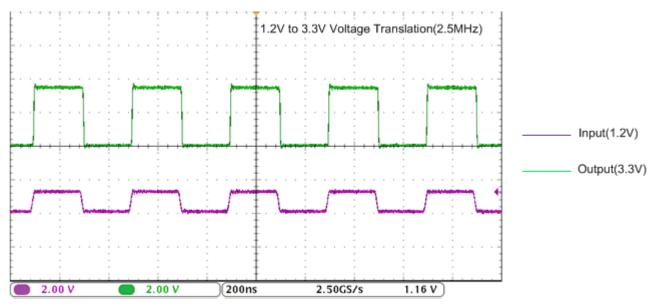


Figure 6. Translation Up (1.2 V to 3.3 V) at 2.5 MHz

SN74AVC4T774

SCES693D - FEBRUARY 2008-REVISED JANUARY 2015



## **11** Power Supply Recommendations

The SN74AVC4T774 device uses two separate configurable power-supply rails, V<sub>CCA</sub> and V<sub>CCB</sub>. V<sub>CCA</sub> accepts any supply voltage from 1.2 V to 3.6 V and V<sub>CCB</sub> accepts any supply voltage from 1.2 V to 3.6 V. The A port and B port are designed to track V<sub>CCA</sub> and V<sub>CCB</sub> respectively allowing for low-voltage, bi-directional translation between any of the 1.2-V, 1.5-V, 1.8-V, 2.5-V and 3.3-V voltage nodes.

The output-enable  $\overline{OE}$  input circuit is designed so that it is supplied by V<sub>CCA</sub> and when the  $\overline{OE}$  input is high, all outputs are placed in the high-impedance state. To ensure the high-impedance state of the outputs during power-up or power-down, the  $\overline{OE}$  input pin must be tied to V<sub>CCA</sub> through a pullup resistor and must not be enabled until V<sub>CCA</sub> and V<sub>CCB</sub> are fully ramped and stable. The minimum value of the pullup resistor to V<sub>CCA</sub> is determined by the current-sinking capability of the driver.

## 12 Layout

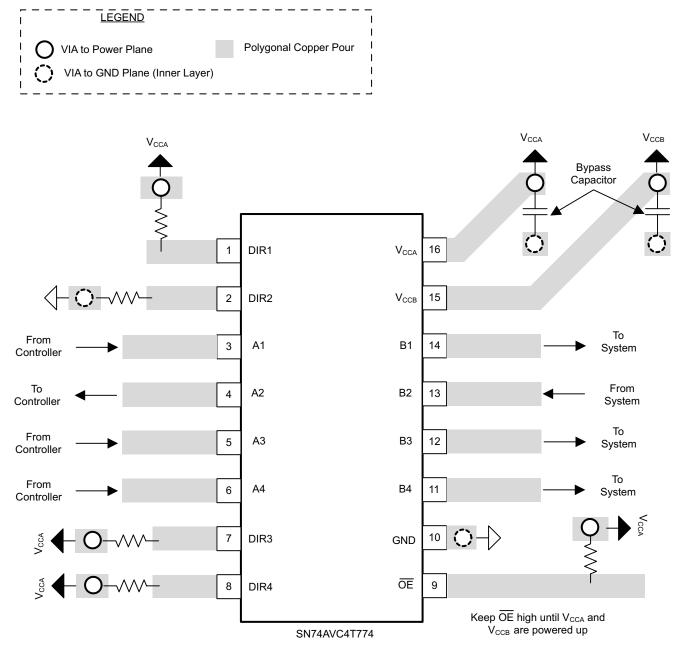
### 12.1 Layout Guidelines

To ensure reliability of the device, following common printed-circuit board layout guidelines are recommended:

- Bypass capacitors should be used on power supplies.
- · Short trace lengths should be used to avoid excessive loading.
- Placing pads on the signal paths for loading capacitors or pullup resistors to help adjust rise and fall times of signals depending on the system requirements



#### 12.2 Layout Example





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# **13 Device and Documentation Support**

## 13.1 Trademarks

All trademarks are the property of their respective owners.

## **13.2 Electrostatic Discharge Caution**



These devices have limited built-in ESD protection. The leads should be shorted together or the device placed in conductive foam during storage or handling to prevent electrostatic damage to the MOS gates.

## 13.3 Glossary

SLYZ022 — TI Glossary.

This glossary lists and explains terms, acronyms, and definitions.

## 14 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.

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## PACKAGING INFORMATION

Orderable Device	Status (1)	Package Type	Package Drawing	Pins	Package Qty	Eco Plan (2)	Lead/Ball Finish	MSL Peak Temp	Op Temp (°C)	Device Marking (4/5)	Samples
74AVC4T774RGYRG4	ACTIVE	VQFN	RGY	16	3000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR	-40 to 85	WT774	Samples
74AVC4T774RSVRG4	ACTIVE	UQFN	RSV	16	3000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	ZVK	Samples
SN74AVC4T774PW	ACTIVE	TSSOP	PW	16	90	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	WT774	Samples
SN74AVC4T774PWG4	ACTIVE	TSSOP	PW	16	90	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	WT774	Samples
SN74AVC4T774PWR	ACTIVE	TSSOP	PW	16	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	WT774	Samples
SN74AVC4T774PWRG4	ACTIVE	TSSOP	PW	16	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	WT774	Samples
SN74AVC4T774RGYR	ACTIVE	VQFN	RGY	16	3000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR	-40 to 85	WT774	Samples
SN74AVC4T774RSVR	ACTIVE	UQFN	RSV	16	3000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	ZVK	Samples

<sup>(1)</sup> The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.

<sup>(2)</sup> Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.

**TBD:** The Pb-Free/Green conversion plan has not been defined.

**Pb-Free (RoHS):** TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.

**Pb-Free (RoHS Exempt):** This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

<sup>(3)</sup> MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.



20-Jan-2015

<sup>(4)</sup> There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

<sup>(5)</sup> Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

<sup>(6)</sup> Lead/Ball Finish - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead/Ball Finish values may wrap to two lines if the finish value exceeds the maximum column width.

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# PACKAGE MATERIALS INFORMATION

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## TAPE AND REEL INFORMATION





## QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



*All dimensions are nominal Device	Package Type	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
SN74AVC4T774PWR	TSSOP	PW	16	2000	330.0	12.4	6.9	5.6	1.6	8.0	12.0	Q1
SN74AVC4T774RGYR	VQFN	RGY	16	3000	330.0	12.4	3.8	4.3	1.5	8.0	12.0	Q1
SN74AVC4T774RSVR	UQFN	RSV	16	3000	180.0	12.4	2.1	2.9	0.75	4.0	12.0	Q1
SN74AVC4T774RSVR	UQFN	RSV	16	3000	178.0	13.5	2.1	2.9	0.75	4.0	12.0	Q1

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# PACKAGE MATERIALS INFORMATION

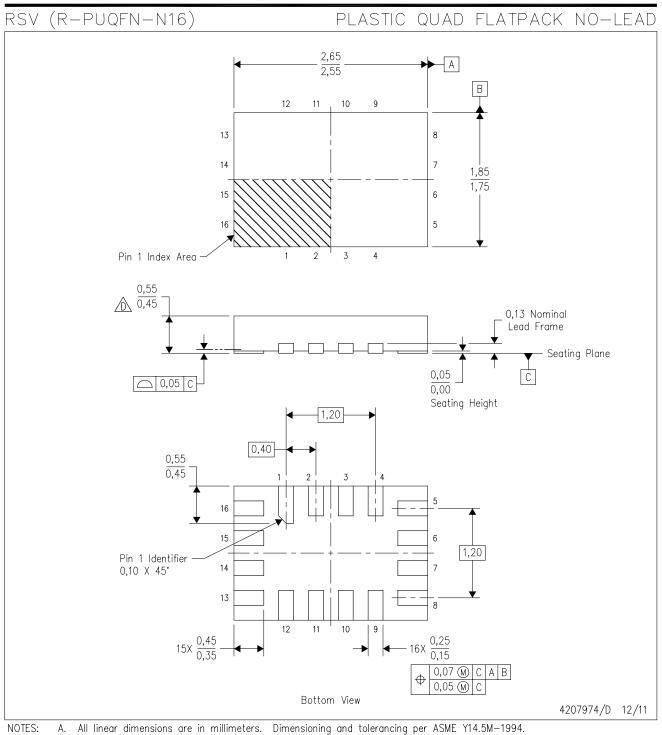
3-Aug-2017



\*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
SN74AVC4T774PWR	TSSOP	PW	16	2000	367.0	367.0	35.0
SN74AVC4T774RGYR	VQFN	RGY	16	3000	367.0	367.0	35.0
SN74AVC4T774RSVR	UQFN	RSV	16	3000	203.0	203.0	35.0
SN74AVC4T774RSVR	UQFN	RSV	16	3000	189.0	185.0	36.0

# **MECHANICAL DATA**



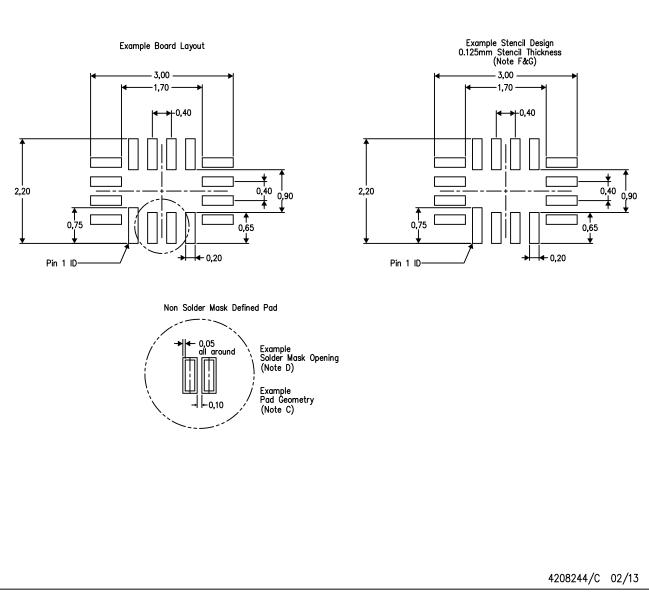
- B. This drawing is subject to change without notice.
- C. QFN (Quad Flatpack No-Lead) package configuration.

ightarrow This package complies to JEDEC MO-288 variation UFHE, except minimum package thickness.



## RSV (R-PUQFN-N16)

PLASTIC QUAD FLATPACK NO-LEAD



NOTES: A. All linear dimensions are in millimeters.

- B. This drawing is subject to change without notice.
- C. Publication IPC-7351 is recommended for alternate designs.
- D. Customers should contact their board fabrication site for minimum solder mask web tolerances between signal pads.
- E. Maximum stencil thickness 0,127 mm (5 mils). All linear dimensions are in millimeters.
- F. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Refer to IPC 7525 for stencil design considerations.
- G. Side aperture dimensions over-print land for acceptable area ratio > 0.66. Customer may reduce side aperture dimensions if stencil manufacturing process allows for sufficient release at smaller opening.



PW (R-PDSO-G16)

PLASTIC SMALL OUTLINE



NOTES:

A. All linear dimensions are in millimeters. Dimensioning and tolerancing per ASME Y14.5M-1994.  $\beta$ . This drawing is subject to change without notice.

Body length does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0,15 each side.

Body width does not include interlead flash. Interlead flash shall not exceed 0,25 each side.

E. Falls within JEDEC MO-153



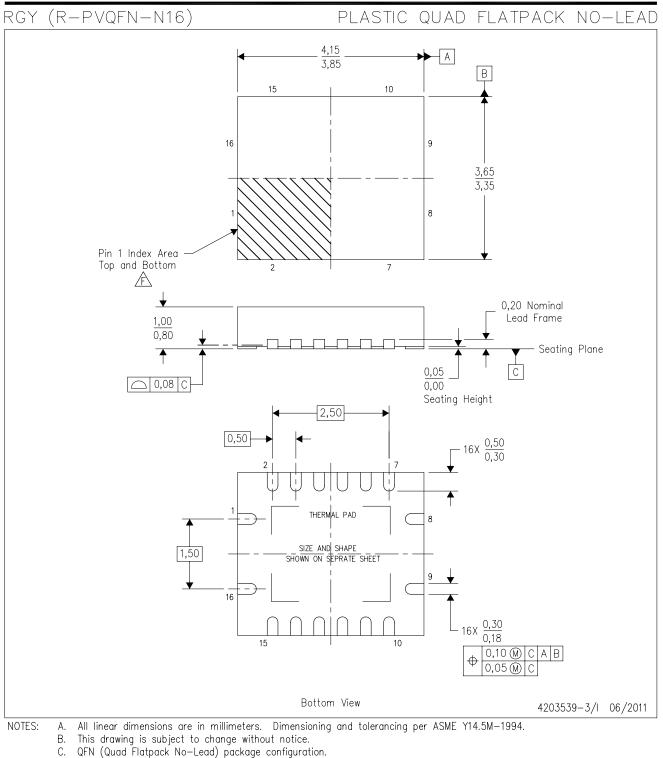


NOTES: A. All linear dimensions are in millimeters.

- B. This drawing is subject to change without notice.
- C. Publication IPC-7351 is recommended for alternate designs.
- D. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Refer to IPC-7525 for other stencil recommendations.
- E. Customers should contact their board fabrication site for solder mask tolerances between and around signal pads.



# **MECHANICAL DATA**



D. The package thermal pad must be soldered to the board for thermal and mechanical performance.

- E. See the additional figure in the Product Data Sheet for details regarding the exposed thermal pad features and dimensions.
- earrow Pin 1 identifiers are located on both top and bottom of the package and within the zone indicated.
- The Pin 1 identifiers are either a molded, marked, or metal feature.
- G. Package complies to JEDEC MO-241 variation BA.



# RGY (R-PVQFN-N16)

## PLASTIC QUAD FLATPACK NO-LEAD

#### THERMAL INFORMATION

This package incorporates an exposed thermal pad that is designed to be attached directly to an external heatsink. The thermal pad must be soldered directly to the printed circuit board (PCB). After soldering, the PCB can be used as a heatsink. In addition, through the use of thermal vias, the thermal pad can be attached directly to the appropriate copper plane shown in the electrical schematic for the device, or alternatively, can be attached to a special heatsink structure designed into the PCB. This design optimizes the heat transfer from the integrated circuit (IC).

For information on the Quad Flatpack No-Lead (QFN) package and its advantages, refer to Application Report, QFN/SON PCB Attachment, Texas Instruments Literature No. SLUA271. This document is available at www.ti.com.

The exposed thermal pad dimensions for this package are shown in the following illustration.



#### NOTE: All linear dimensions are in millimeters





NOTES: A. All linear dimensions are in millimeters.

- B. This drawing is subject to change without notice.
- C. Publication IPC-7351 is recommended for alternate designs.

D. This package is designed to be soldered to a thermal pad on the board. Refer to Application Note, Quad Flat-Pack QFN/SON PCB Attachment, Texas Instruments Literature No. SLUA271, and also the Product Data Sheets for specific thermal information, via requirements, and recommended board layout. These documents are available at www.ti.com <a href="http://www.ti.com">http://www.ti.com</a>.

- E. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Refer to IPC 7525 for stencil design considerations.
- F. Customers should contact their board fabrication site for minimum solder mask web tolerances between signal pads.



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